INTEGRATED CIRCUITS

DATA SHEET

74ALVT162821

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

Product specification Supersedes data of 1997 Feb 13 IC23 Data Handbook





2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30 Ω termination resistors (3-State)

74ALVT162821

FEATURES

- Outputs include series resistance of 30Ω making external termination resistors unnecessary
- 20-bit positive-edge triggered register
- 5V I/O Compatible
- Multiple V_{CC} and GND pins minimize switching noise
- Live insertion/extraction permitted
- Power-up reset
- Power-up 3-State
- Output capability +12mA/-12mA
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model
- Bus hold data inputs eliminate the need for external pull-up resistors to hold unused inputs

DESCRIPTION

The 74ALVT162821 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive. It is designed for V_{CC} operation at 2.5V or 3.3V with I/O compatibility to 5V.

The 74ALVT162821 has two 10-bit, edge triggered registers, with each register coupled to a 3-State output buffer. The two sections of each register are controlled independently by the clock (nCP) and Output Enable (nOE) control gates.

Each register is fully edge triggered. The state of each D input, one set-up time before the Low-to-High clock transition, is transferred to the corresponding flip-flop's Q output.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors.

The active Low Output Enable ($n\overline{OE}$) controls all ten 3-State buffers independent of the register operation. When $n\overline{OE}$ is Low, the data in the register appears at the outputs. When $n\overline{OE}$ is High, the outputs are in high impedance "off" state, which means they will neither drive nor load the bus.

The 74ALVT162821 is designed with 30Ω series resistance in both High and Low output stages. This design reduces the line noise in applications such as memory address drivers, clock drivers and bus receivers/transmitters. The series termination resistors reduce overshoot and undershoot and are ideal for driving memory arrays.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYPI	UNIT	
STIMBOL	FARAMETER	T _{amb} = 25°C	2.5V	3.3V	ONIT
t _{PLH} t _{PHL}	Propagation delay nCP to nQ	C _L = 50pF	4.4 3.8	3.2 3.2	ns
C _{IN}	Input capacitance	V _I = 0V or V _{CC}	3	3	pF
C _{OUT}	Output capacitance	$V_O = 0$ or V_{CC}	9	9	pF
I _{CCZ}	Total supply current	Outputs disabled	40	70	μΑ

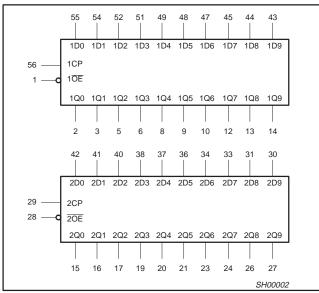
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type III	-40°C to +85°C	74ALVT162821 DL	AV162821 DL	SOT371-1
56-Pin Plastic TSSOP Type II	-40°C to +85°C	74ALVT162821 DGG	AV162821 DGG	SOT364-1

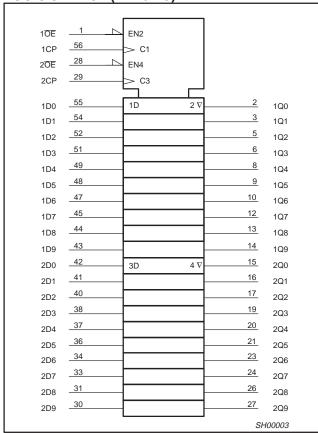
2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

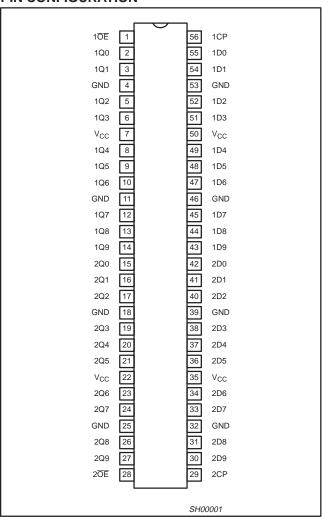
LOGIC SYMBOL



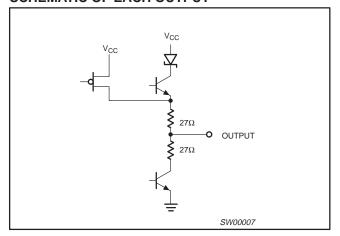
LOGIC SYMBOL (IEEE/IEC)



PIN CONFIGURATION



SCHEMATIC OF EACH OUTPUT



2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
55, 54, 52, 51, 49, 48, 47, 45, 44, 43, 42, 41, 40, 38, 37, 36, 34, 33, 31, 30	1D0 - 1D9 2D0 - 2D9	Data inputs
2, 3, 5, 6, 8, 9, 10, 12, 13, 14, 15, 16, 17, 19, 20, 21, 23, 24, 26, 27	1Q0 - 1Q9 2Q0 - 2Q9	Data outputs
1, 28	1 0E , 2 0E	Output enable inputs (active-Low)
56, 29	1CP, 2CP	Clock pulse inputs (active rising edge)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

FUNCTION TABLE

I	NPUTS	5	INTERNAL	OUTPUTS	OPERATING
nOE	nCP	nDx	REGISTER	nQ0 - nQ9	MODE
L	\uparrow	l h	L H	L H	Load and read register
L	1	Х	NC	NC	Hold
H		X Dn	NC Dn	Z Z	Disable outputs

H = High voltage level
h = High voltage level one set-up time prior to the Low-to-High clock transition

Low voltage level

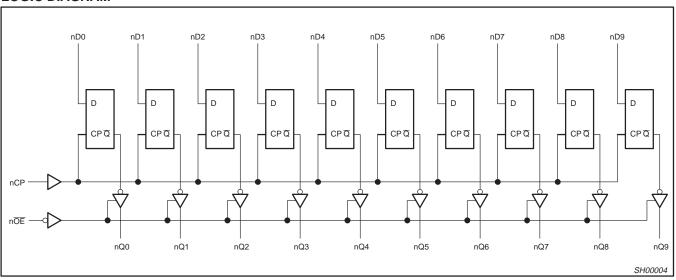
Low voltage level one set-up time prior to the Low-to-High clock transition

No change

Don't care

High impedance "off" state
Low to High clock transition
Not a Low-to-High clock transition

LOGIC DIAGRAM



2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

ABSOLUTE MAXIMUM RATINGS1, 2

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V _I < 0	-50	mA
VI	DC input voltage ³		-1.2 to +7.0	V
lok	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
	DC output ourrent	Output in Low state	128	A
Гоит	DC output current	Output in High state	-64	mA
T _{stg}	Storage temperature range		-65 to 150	°C

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction
- temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
- 3. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	2.5V RANG	GE LIMITS	3.3V RANG	UNIT	
STMBOL	FARAMETER	MIN	MAX	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
VI	Input voltage	0	5.5	0	5.5	V
V _{IH}	High-level input voltage	1.7		2.0		V
V _{IL}	Input voltage		0.7		8.0	V
I _{OH}	High-level output current		-8		-12	mA
I _{OL}	Low-level output current		12		12	mA
Δt/Δν	Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	-40	+85	°C

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

DC ELECTRICAL CHARACTERISTICS (3.3V \pm 0.3V RANGE)

				'	LIMITS		1
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 3.0V; I_{IK} = -18mA$			-0.85	-1.2	V
\/	High-level output voltage	$V_{CC} = 3.0 \text{ to } 3.6 \text{V}; I_{OH} = -100 \mu\text{A}$		V _{CC} -0.2	V _{CC}		V
V_{OH}	High-level output voltage	$V_{CC} = 3.0V; I_{OH} = -32mA$		2.0	2.3		
		$V_{CC} = 3.0V; I_{OL} = 100\mu A$			0.07	0.2	
V	Low-level output voltage	V _{CC} = 3.0V; I _{OL} = 16mA			0.25	0.4	_v
V_{OL}	Low-level output voltage	$V_{CC} = 3.0V; I_{OL} = 32mA$			0.3	0.5	ľ
		$V_{CC} = 3.0V; I_{OL} = 64mA$			0.4	0.55	
V _{RST}	Power-up output low voltage ⁶	$V_{CC} = 3.6V$; $I_{O} = 1mA$; $V_{I} = V_{CC}$ or GND				0.55	٧
		$V_{CC} = 3.6V$; $V_I = V_{CC}$ or GND	Control pins		0.1	±1	
	Input lookaga gurrant	$V_{CC} = 0 \text{ or } 3.6V; V_{I} = 5.5V$			0.1	10	
łı	Input leakage current	$V_{CC} = 3.6V; V_{I} = V_{CC}$	Data pins ⁴		0.5	1	μΑ
		$V_{CC} = 3.6V; V_{I} = 0V$	Data pins .		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$			0.1	±100	μΑ
	Bus Hold current	$V_{CC} = 3V; V_{I} = 0.8V$		75	130		
I_{HOLD}		$V_{CC} = 3V; V_{I} = 2.0V$		-75	-140		μΑ
	Data inputs ⁷	$V_{CC} = 0V \text{ to } 3.6V; V_{CC} = 3.6V$		±500			
I _{EX}	Current into an output in the High state when V _O > V _{CC}	V _O = 5.5V; V _{CC} = 3.0V			10	125	μА
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GNDOE/OE$ = Don't care	or V _{CC}		1	±100	μΑ
I _{OZH}	3-State output High current	$V_{CC} = 3.6V; V_{O} = 3.0V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	5	μΔ
I _{OZL}	3-State output Low current	$V_{CC} = 3.6V$; $V_O = 0.5V$; $V_I = V_{IL}$ or V_{IH}			0.5	-5	μΑ
Іссн		$V_{CC} = 3.6V$; Outputs High, $V_{I} = GND$ or $V_{I} = V_{I} = V_{I$	V _{CC,} I _{O =} 0		0.07	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 3.6V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_{O} = 0$			5.1	7	m/
I _{CCZ}	1	V _{CC} = 3.6V; Outputs Disabled; V _I = GND	or V_{CC} , $I_{O} = 0^5$		0.07	0.1	1
Δl _{CC}	Additional supply current per input pin ²	V_{CC} = 3V to 3.6V; One input at V_{CC} -0.6° Other inputs at V_{CC} or GND	V,		0.04	0.4	m <i>P</i>

- All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
 This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 3.3V ± 0.2V a transition time of 100 μ sec is permitted. This parameter is valid for $T_{amb} = 25$ °C only.
- 4. Unused pins at V_{CC} or GND.
- 5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
 6. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
- 7. This is the bus hold overdrive current required to force the input to the opposite logic state.

AC CHARACTERISTICS (3.3V \pm 0.3V RANGE) GND = 0V; $t_R = t_F = 2.5 ns; C_L = 50 pF; R_L = 500 \Omega; T_{amb} = -40 ^{\circ} C$ to +85 $^{\circ} C$.

				LIMITS			
SYMBOL	PARAMETER	PARAMETER WAVEFORM		T _{amb} = -40 to +85°C V _{CC} = +3.3V			
			MIN	TYP	MAX		
f _{MAX}	Maximum clock frequency	1	150			MHz	
t _{PLH} t _{PHL}	Propagation delay nCP to nQx	1	1.0 1.0	3.2 3.2	5.0 4.7	ns	
t _{PZH} t _{PZL}	Output enable time to High and Low level	3 4	1.0 0.5	3.4 2.3	5.6 3.7	ns	
^t PHZ ^t PLZ	Output disable time from High and Low level	3 4	1.5 1.5	3.7 3.0	5.4 4.3	ns	

^{1.} All typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25$ °C.

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

AC SETUP REQUIREMENTS (3.3V $\pm 0.3V$ RANGE) GND = 0V, $t_R = t_F = 2.5 ns, \, C_L = 50 pF, \, R_L = 500 \Omega$

			LIN	IITS	
SYMBOL	PARAMETER	WAVEFORM	T _{amb} = -40 to +85°C V _{CC} = +3.3V ±0.3V		UNIT
			MIN	TYP]
t _S (H) t _S (L)	Setup time, High or Low nDx to nCP	1	1.5 1.5	0.1 0.1	ns
t _h (H) t _h (L)	Hold time, High or Low nDx to nCP	2	0.5 0.5	0.1 0.1	ns
t _w (H) t _w (L)	nCP pulse width High or Low	2	1.5 1.5		ns

DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		Temp = -40°C to		+85°C	רואט
				MIN	TYP ¹	MAX	1
V _{IK}	Input clamp voltage	$V_{CC} = 2.3V; I_{IK} = -18mA$	V _{CC} = 2.3V; I _{IK} = -18mA		-0.85	-1.2	V
\/	High-level output voltage	$V_{CC} = 2.3 \text{ to } 3.6 \text{V}; I_{OH} = -100 \mu\text{A}$		V _{CC} -0.2	V _{CC}		V
V _{OH}	High-level output voltage	$V_{CC} = 2.3V; I_{OH} = -8mA$		1.8	2.1		1 °
		$V_{CC} = 2.3V; I_{OL} = 100\mu A$			0.07	0.2	
V_{OL}	Low-level output voltage	$V_{CC} = 2.3V; I_{OL} = 24mA$			0.3	0.5	V
		$V_{CC} = 2.3V; I_{OL} = 8mA$				0.4	
V _{RST}	Power-up output low voltage ⁷	$V_{CC} = 2.7V$; $I_{O} = 1$ mA; $V_{I} = V_{CC}$ or GND				0.55	V
		$V_{CC} = 2.7V$; $V_I = V_{CC}$ or GND	Control pins		0.1	±1	
	Input leakage current	$V_{CC} = 0 \text{ or } 2.7V; V_{I} = 5.5V$			0.1	10	μΑ
I ₁	Input leakage current	$V_{CC} = 2.7V; V_{I} = V_{CC}$	Data pins ⁴		0.1	1	
		$V_{CC} = 2.7V; V_I = 0$	Data pins		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V$; V_{I} or $V_{O} = 0$ to 4.5V			0.1	±100	μΑ
I _{HOLD}	Bus Hold current	$V_{CC} = 2.3V; V_I = 0.7V$			90		μΑ
	Data inputs ⁶	$V_{CC} = 2.3V; V_I = 1.7V$			-10		μА
I _{EX}	Current into an output in the High state when V _O > V _{CC}	V _O = 5.5V; V _{CC} = 2.3V			10	125	μА
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GNDOE/OE = Don't$ care	or V _{CC}		1	±100	μА
I _{OZH}	3-State output High current	$V_{CC} = 2.7V; V_{O} = 2.3V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	5	μΑ
I _{OZL}	3-State output Low current	$V_{CC} = 2.7V$; $V_{O} = 0.5V$; $V_{I} = V_{IL}$ or V_{IH}	$V_{CC} = 2.7V; V_O = 0.5V; V_I = V_{IL} \text{ or } V_{IH}$		0.5	- 5	μΑ
I _{CCH}		$V_{CC} = 2.7V$; Outputs High, $V_{I} = GND$ or V_{CC} , $I_{O} = 0$			0.04	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_{O} = 0$			2.3	4.5	mΑ
I _{CCZ}]	V_{CC} = 2.7V; Outputs Disabled; V_I = GND	or V_{CC} , $I_{O} = 0^5$		0.04	0.1	1
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 2.3V to 2.7V; One input at V_{CC} -0. Other inputs at V_{CC} or GND	6V,		0.04	0.4	mA

NOTES:

- All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
- 3. This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 2.5V \pm 0.3V a transition time of 100 μ sec is permitted. This parameter is valid for T_{amb} = 25°C only.
- 4. Unused pins at V_{CC} or GND.
- 5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
 6. Not guaranteed.
- 7. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

AC CHARACTERISTICS (2.5V \pm 0.2V RANGE) GND = 0V; $t_R = t_F = 2.5 ns; \ C_L = 50 pF; \ R_L = 500 \Omega; \ T_{amb} = -40 ^{\circ} C$ to +85 $^{\circ} C.$

SYMBOL	PARAMETER	PARAMETER WAVEFORM		T _{amb} = -40 to +85°C V _{CC} = +2.5V ±0.2V			
			MIN	TYP	MAX		
f _{MAX}	Maximum clock frequency	1	150			MHz	
t _{PLH} t _{PHL}	Propagation delay nCP to nQx	1	1.0 1.0	4.4 3.8	7.0 6.4	ns	
t _{PZH} t _{PZL}	Output enable time to High and Low level	3 4	1.5 1.0	4.6 2.8	7.5 4.6	ns	
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	3 4	1.5 1.0	3.5 3.7	5.5 5.7	ns	

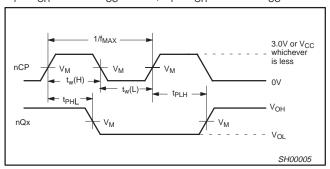
NOTE:

AC SETUP REQUIREMENTS (2.5V \pm 0.2V RANGE) GND = 0V, $t_R=t_F=2.5 ns,\, C_L=50 pF,\, R_L=500\Omega$

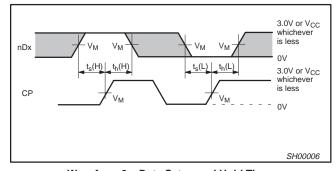
			LIN				
SYMBOL	PARAMETER	WAVEFORM	T_{amb} = -40 to +85°C V_{CC} = +2.5 ±0.2V		WAVEFORM $T_{amb} = -40 \text{ to } +85^{\circ}\text{C}$ $V_{CC} = +2.5 \pm 0.2\text{V}$		UNIT
			MIN	TYP			
t _s (H) t _s (L)	Setup time, High or Low nDx to nCP	1	1.5 2.0	0.1 0.5	ns		
t _h (H) t _h (L)	Hold time, High or Low nDx to nCP	2	0.3 0.5	-0.5 -0.1	ns		
t _w (H) t _w (L)	nCP pulse width High or Low	2	1.5 1.5		ns		

AC WAVEFORMS

 V_M = 1.5V at V_{CC} ≥ 3.0V; V_M = $V_{CC}/2$ at V_{CC} ≤ 2.7V V_X = V_{OL} + 0.3V at V_{CC} ≥ 3.0V; V_X = V_{OL} + 0.15V at V_{CC} ≤ 2.7V V_Y = V_{OH} - 0.3V at V_{CC} ≥ 3.0V; V_Y = V_{OH} - 0.15V at V_{CC} ≤ 2.7V



Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock frequency

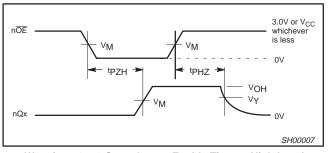


Waveform 2. Data Setup and Hold Times

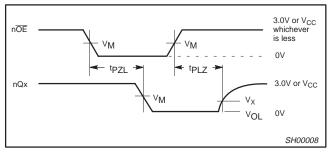
^{1.} All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.

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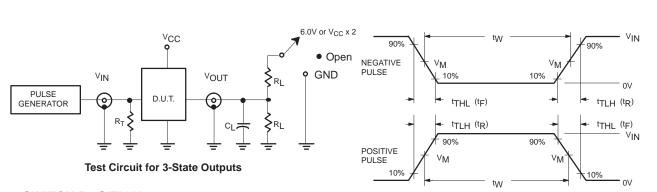


Waveform 3. 3-State Output Enable Time to High Level and Output Disable Time from High Level



Waveform 4. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

TEST CIRCUIT AND WAVEFORM



SWITCH POSITION

TEST	SWITCH
t _{PLZ} /t _{PZL}	6V or V _{CC x 2}
t _{PLH} /t _{PHL}	Open
t _{PHZ} /t _{PZH}	GND

DEFINITIONS

 R_L = Load resistor; see AC CHARACTERISTICS for value.

 $C_L = Load$ capacitance includes jig and probe capacitance: See AC CHARACTERISTICS for value.

FAMILY	INPUT PULSE REQUIREMENTS								
FAMILY	Amplitude	Rep. Rate	t _W	t _R	t _F				
74ALVT16	3.0V or V _{CC} whichever is less	≤10MHz	500ns	≤2.5ns	≤2.5ns				

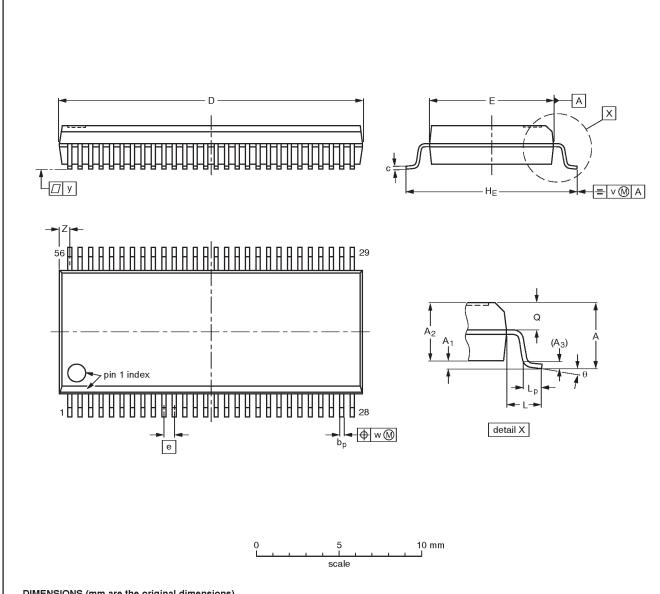
SW00025

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	Α ₁	A ₂	A ₃	рb	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	18.55 18.30	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

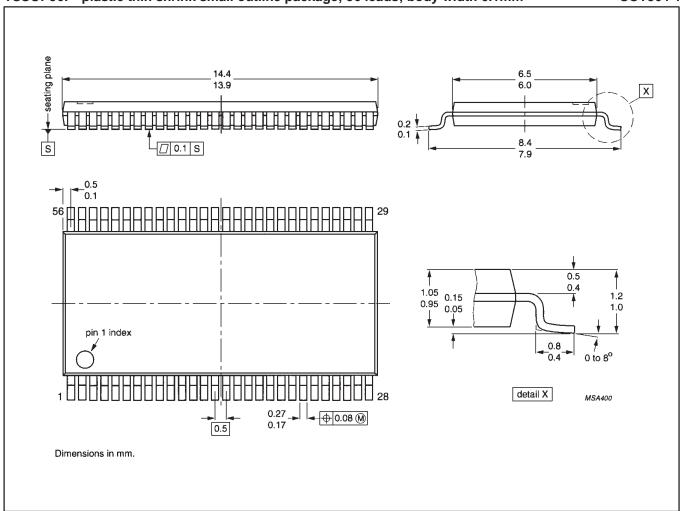
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT371-1		MO-118AB			93-11-02 95-02-04

2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1mm

SOT364-1



2.5V/3.3V 20-bit bus-interface D-type flip-flop; positive-edge trigger with 30Ω termination resistors (3-State)

74ALVT162821

Data sheet status

Data sheet status	Product status	Definition [1]
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